# PURDUE **UNIVERSITY**

School of Materials Engineering

## **Bi-containing SnAgCu Alloys: Material property** evaluation for advanced semiconductor devices

precipitates

the interface

dendrites

~0-75 µm above

~0-50 µm above

the interface

■SAC305

SAC305+1wt% Bi SAC305+2wt% B

SAC305+3wt% Bi

**Dominic Hurley, Julia Peck, Yew Wei See, Ashley Wissel** Faculty Advisors: Dr. John Blendell and Dr. Carol Handwerker Industrial Sponsors: Dr. Peng Su, Juniper Networks

Body sizes of high performance semiconductor devices have been increasing to meet performance and functionality demands. Stress and strain caused by mismatches in CTE between circuit boards and these components are exacerbated by these increases. Solder joint fatigue life can worsen because of these increases in stress and strain. New and potentially more creep resistant solder is needed to improve the long term reliability of the product. In this work we report preliminary mechanical testing results of SAC305 + Bi and also findings from a critical review of literature.

This project was funded by Juniper Networks.



#### Background Discussion **Results Solidification** Microstructure **Material Properties** Liquidus projection of SAC > Stress-strain curves at elevated temperatures for phase diagram [1] 100 µm

>>217°C eutectic temp ➤ Microconstituents may be predicted from phase diagram

**Microstructure** 



 $>\beta$ -Sn dendrites [2] ≻ Brittle IMCs during form

Ag<sub>3</sub>Sn +β-Sn

annealing  $\circ Cu_6Sn_5$ 

- $\circ$  Ag<sub>3</sub>Sn
- addition strengthens for ≻ Bi concentrations up to 2%

**Creep in Solder**:

- Reduces IMC formation
- ➤ Temperature dependent
- > Stress dependent [3]
- > Negatively affected by microstructural coarsening (includes IMC growth)





- ➤ ThermoCalc TCSLD3: Solder Alloy Database v 3.2 [7] ➤ Scheil (non-equilibrium) solidification) paths (solid lines) Can be used to explain microstructures that differ from those predicted from
  - equilibrium phase diagram

- SAC305 (a) and SAC\_Q (Sn-3.4Ag-0.5Cu-3.3Bi) (b) showing experimental data and Anand model fit [9]
- > Bi-containing alloys have higher yield strength compared to similar alloys with no Bi due to solidsolution strengthening and Bi precipitates.



#### **Experimental Procedure**

**Reflow and PCB Preparation:** 

≻Kester TSF 6522 No-Clean Tacky Flux used ► JEDEC reflow profile





- > SAC305 +2 wt% Bi possessed greatest shear strength
  - Fast shear (5 mm/s)
  - Slow shear (0.5 mm/s)
- > Linear increase in strength until 2 wt% Bi
  - $\circ$  x = ± 3 x standard deviation



> Bulk solder creep/tensile testing

**Future Work** 

- Comprehensive ball shear / microhardness testing
- > Optical/BSE SEM microstructural imaging

#### Summary

review of ball shear data and Based on a literature, the team recommends the alloy SAC305 + 2%Bi due to its improved mechanical properties over SAC305. The team recommends further testing of microhardness, ball shear performance, and bulk creep properties of this composition both aged and as-reflowed to better characterize the mechanical behavior.

- 4 6 8 % Bi Substitution for Sn > Average shear strength in different Bi %Bi from literature[8] > Our shear strength data match with the literature (b) (a) SAC305 + 3 wt% Bi SAC305 + 1.5 wt% Bi
- > (a) Large Ag<sub>3</sub>Sn IMC plates with Bi matrix in solid solution of  $\beta$ -Sn at 1.5wt%Bi
- > (b) Finer Ag<sub>3</sub>Sn IMC plates, Bi precipitates at 3wt% [8]

### Acknowledgements

The team would like to thank Dr. Peng Su for his project oversight, Dr. John Holaday and his colleagues at NSWC Crane for conducting ball shear testing, and graduate students Yaohui Fan, Hannah Fowler, and Yifan Wu for their assistance.



MSE 430-440: Materials Processing and Design